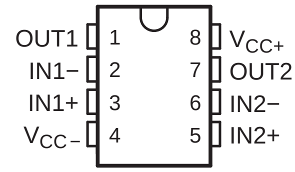
FEATURES

- **Dual-Supply Operation . . . ±5 V to ±18 V**
- **Low Noise Voltage . . . 4.5 nV/√Hz**
- **Low Input Offset Voltage . . . 0.15 mV**
- **Low Total Harmonic Distortion . . . 0.002%**
- **High Slew Rate . . . 7 V/μs**
- **High-Gain Bandwidth Product . . . 16 MHz**
- **High Open-Loop AC Gain . . . 800 at 20 kHz**
- **Large Output-Voltage Swing . . . 14.1 V to –14.6 V**
- **Excellent Gain and Phase Margins**

**D (SOIC), DGK (MSOP), OR P (PDIP) PACKAGE
(TOP VIEW)**



DESCRIPTION/ORDERING INFORMATION

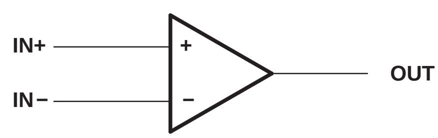
The MC33078 is a bipolar dual operational amplifier with high-performance specifications for use in quality audio and data-signal applications. This device operates over a wide range of single- and dual-supply voltages and offers low noise, high-gain bandwidth, and high slew rate. Additional features include low total harmonic distortion, excellent phase and gain margins, large output voltage swing with no deadband crossover distortion, and symmetrical sink/source performance.

ORDERING INFORMATION

T_A	PACKAGE(1)		ORDERABLE PART NUMBER	TOP-SIDE MARKING(2)
–40°C to 85°C	PDIP – P	Tube of 50	MC33078P	MC33078P
	SOIC – D	Tube of 75	MC33078D	M33078
		Reel of 2500	MC33078DR	
	VSSOP/MSOP – DGK	Reel of 2500	MC33078DGKR	MY_
		Reel of 250	MC33078DGKT	

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.
(2) DGK: The actual top-side marking has one additional character that designates the assembly/test site.

SYMBOL (EACH AMPLIFIER)



Absolute Maximum Ratings[1]

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC+}	Supply voltage[2]			18	V
V_{CC-}	Supply voltage[2]			–18	V
$V_{CC+} – V_{CC-}$	Supply voltage			36	V
	Input voltage, either input[2][3]			V_{CC+} or V_{CC-}	V
	Input current[4]			±10	mA
	Duration of output short circuit[5]			Unlimited	
θ_{JA}	Package thermal impedance, junction to free air[6][7]	D package		97	°C/W
		DGK package		172	
		P package		85	
T_J	Operating virtual junction temperature			150	°C
T_{stg}	Storage temperature range		–65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) All voltage values, except differential voltages, are with respect to the midpoint between V_{CC+} and V_{CC-}.
(3) The magnitude of the input voltage must never exceed the magnitude of the supply voltage.
(4) Excessive input current will flow if a differential input voltage in excess of approximately 0.6 V is applied between the inputs, unless some limiting resistance is used.
(5) The output may be shorted to ground or either power supply. Temperature and/or supply voltages must be limited to ensure the maximum dissipation rating is not exceeded.
(6) Maximum power dissipation is a function of T_J(max), θ_{JA}, and T_A. The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_J(max) – T_A)/\theta_{JA}$. Operating at the absolute maximum T_J of 150°C can affect reliability.
(7) The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions

		MIN	MAX	UNIT
V_{CC-}	Supply voltage	–5	–18	V
V_{CC+}		5	18	
T_A	Operating free-air temperature range	–40	85	°C

Electrical Characteristics

V_{CC-} = –15 V, V_{CC+} = 15 V, T_A = 25°C (unless otherwise noted)

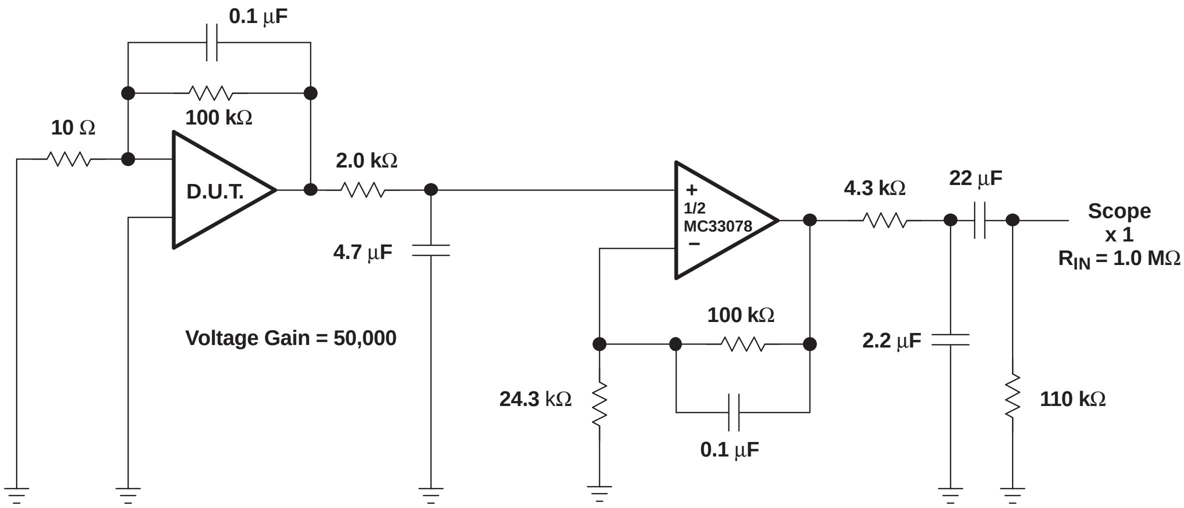
PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
V_{IO}	Input offset voltage	V_O = 0, R_S = 10 Ω, V_{CM} = 0		T_A = 25°C		0.15	2	mV
				T_A = –40°C to 85°C			3	
αV_{IO}	Input offset voltage temperature coefficient	V_O = 0, R_S = 10 Ω, V_{CM} = 0		T_A = –40°C to 85°C		2		µV/°C
I_{IB}	Input bias current	V_O = 0, V_{CM} = 0		T_A = 25°C		300	750	nA
				T_A = –40°C to 85°C			800	
I_{IO}	Input offset current	V_O = 0, V_{CM} = 0		T_A = 25°C		25	150	nA
				T_A = –40°C to 85°C			175	
V_{ICR}	Common-mode input voltage range	ΔV_{IO} = 5 mV, V_O = 0			±13	±14		V
A_{VD}	Large-signal differential voltage amplification	R_L ≥ 2 kΩ, V_O = ±10 V		T_A = 25°C	90	110		dB
				T_A = –40°C to 85°C	85			
V_{OM}	Maximum output voltage swing	V_{ID} = ±1 V	R_L = 600 Ω	V_{OM+}		10.7		V
				V_{OM-}		–11.9		
			R_L = 2k Ω	V_{OM+}	13.2	13.8		
				V_{OM-}	–13.2	–13.7		
			R_L = 10k Ω	V_{OM+}	13.5	14.1		
				V_{OM-}	–14	–14.6		
CMMR	Common-mode rejection ratio	V_{IN} = ±13 V			80	100		dB
k_{SVR} (1)	Supply-voltage rejection ratio	V_{CC+} = 5 V to 15 V, V_{CC-} = –5 V to –15 V			80	105		dB
I_{OS}	Output short-circuit current	$\|V_{ID}\|$ = 1 V, Output to GND		Source current	15	29		mA
				Sink current	–20	–37		
I_{CC}	Supply current (per channel)	V_O = 0		T_A = 25°C		2.05	2.5	mA
				T_A = –40°C to 85°C			2.75	

(1) Measured with $V_{CC\pm}$ differentially varied at the same time

Operating Characteristics

V_{CC-} = –15 V, V_{CC+} = 15 V, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
SR	Slew rate at unity gain	A_{VD} = 1, V_{IN} = –10 V to 10 V, R_L = 2 kΩ, C_L = 100 pF		5	7		V/µs
GBW	Gain bandwidth product	f = 100 kHz		10	16		MHz
B_1	Unity gain frequency	Open loop			9		MHz
G_m	Gain margin	R_L = 2 kΩ	C_L = 0 pF		–11		dB
			C_L = 100 pF		–6		
Φ_m	Phase margin	R_L = 2 kΩ	C_L = 0 pF		55		deg
			C_L = 100 pF		40		
	Amp-to-amp isolation	f = 20 Hz to 20 kHz			–120		dB
	Power bandwidth	V_O = 27 $V_{(PP)}$, R_L = 2 kΩ, THD ≤ 1%			120		kHz
THD	Total harmonic distortion	V_O = 3 V_{rms}, A_{VD} = 1, R_L = 2 kΩ, f = 20 Hz to 20 kHz			0.002		%
z_o	Open-loop output impedance	V_O = 0, f = 9 MHz			37		Ω
r_{id}	Differential input resistance	V_{CM} = 0			175		kΩ
C_{id}	Differential input capacitance	V_{CM} = 0			12		pF
V_n	Equivalent input noise voltage	f = 1 kHz, R_S = 100 Ω			4.5		nV/√Hz
I_n	Equivalent input noise current	f = 1 kHz			0.5		pA/√Hz

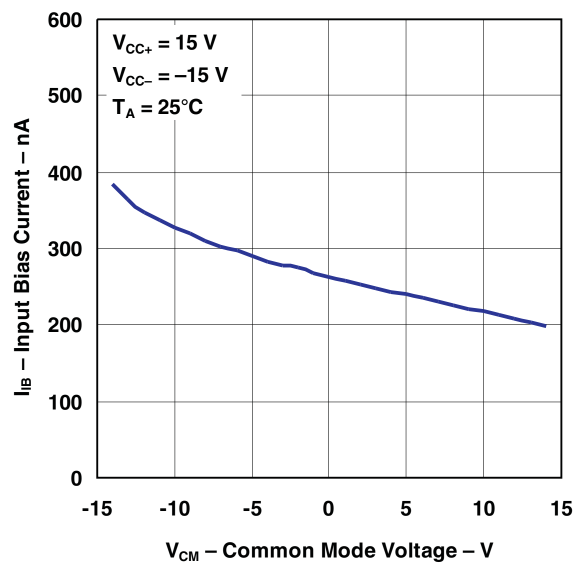


NOTE: All capacitors are non-polarized.

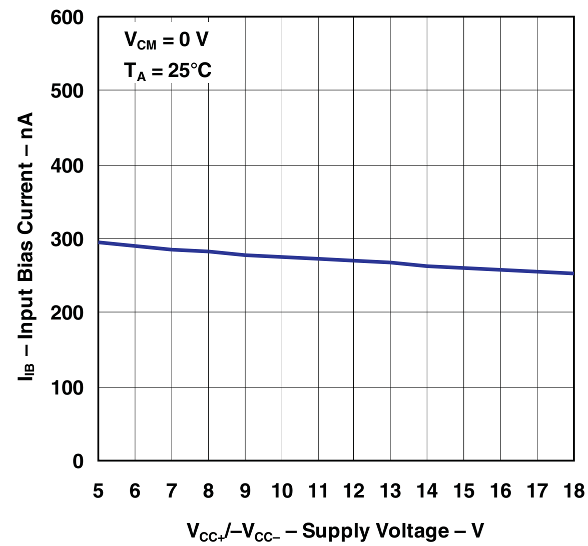
Figure 1. Voltage Noise Test Circuit (0.1 Hz to 10 Hz)

TYPICAL CHARACTERISTICS

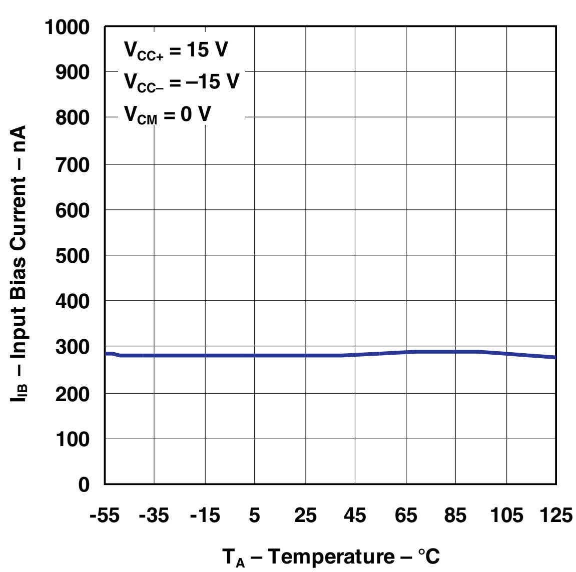
INPUT BIAS CURRENT
vs
COMMON-MODE VOLTAGE



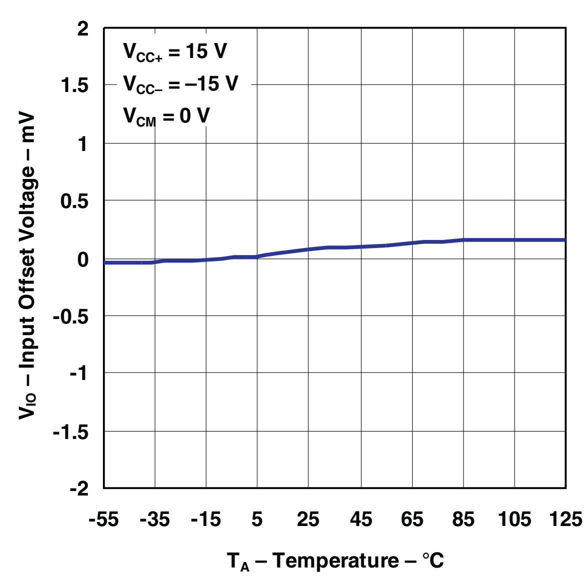
INPUT BIAS CURRENT
vs
SUPPLY VOLTAGE



INPUT BIAS CURRENT
vs
TEMPERATURE

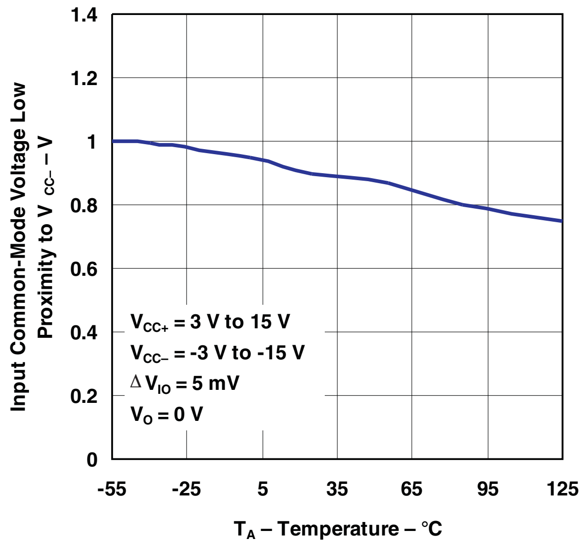


INPUT OFFSET VOLTAGE
vs
TEMPERATURE

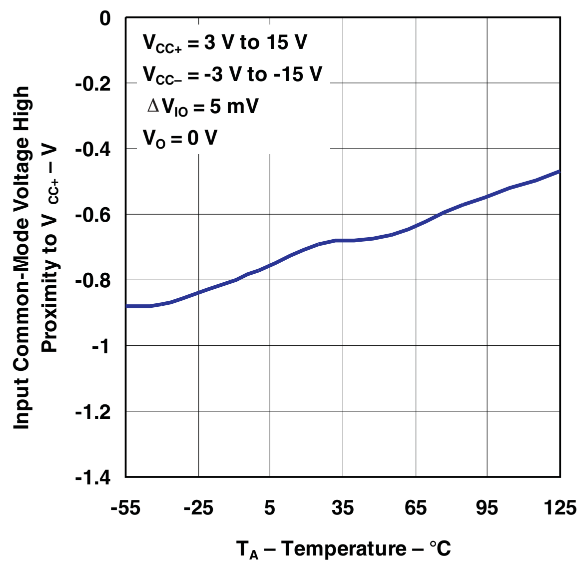


TYPICAL CHARACTERISTICS (continued)

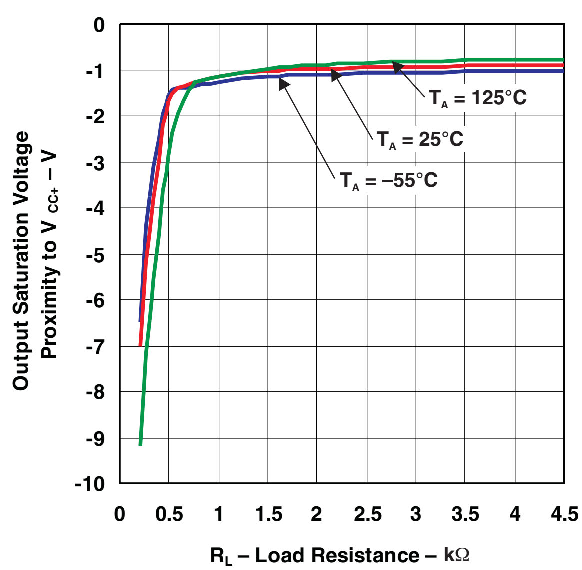
INPUT COMMON-MODE VOLTAGE
LOW PROXIMITY TO V_{CC-}
vs
TEMPERATURE



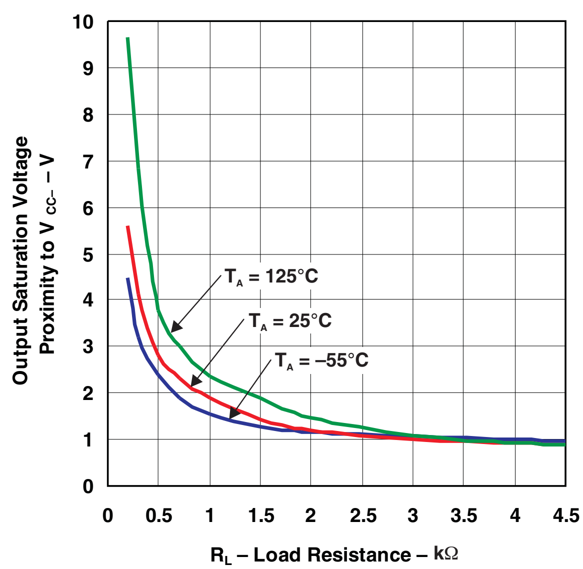
INPUT COMMON-MODE VOLTAGE
HIGH PROXIMITY TO V_{CC+}
vs
TEMPERATURE



OUTPUT SATURATION VOLTAGE PROXIMITY TO V_{CC+}
vs
LOAD RESISTANCE

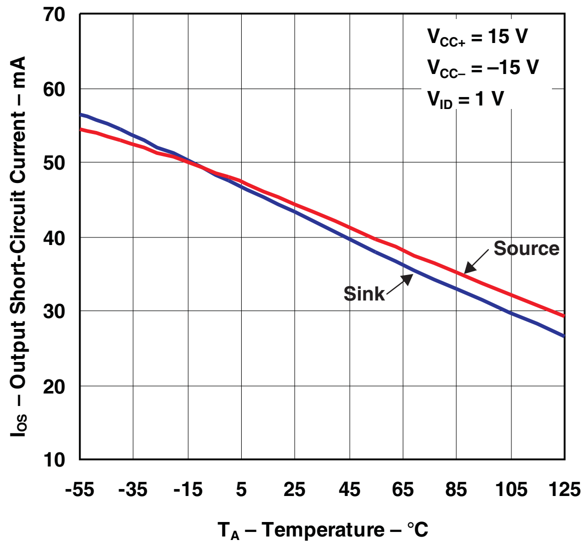


OUTPUT SATURATION VOLTAGE PROXIMITY TO V_{CC-}
vs
LOAD RESISTANCE

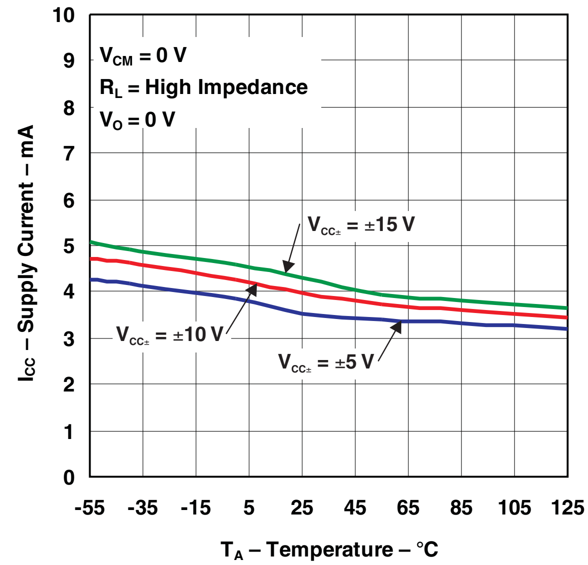


TYPICAL CHARACTERISTICS (continued)

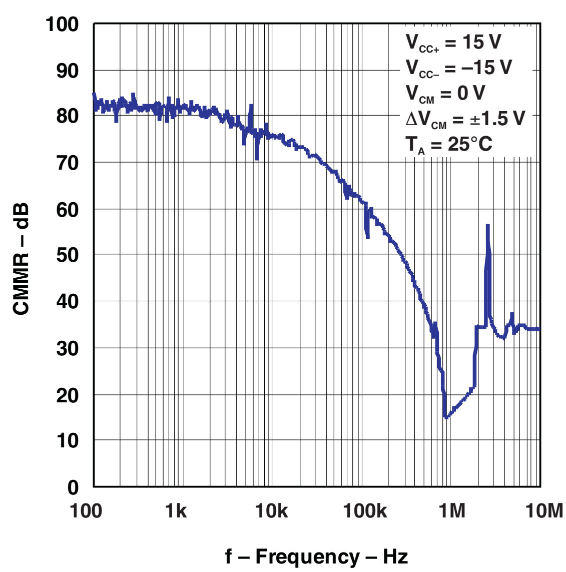
OUTPUT SHORT-CIRCUIT CURRENT
vs
TEMPERATURE



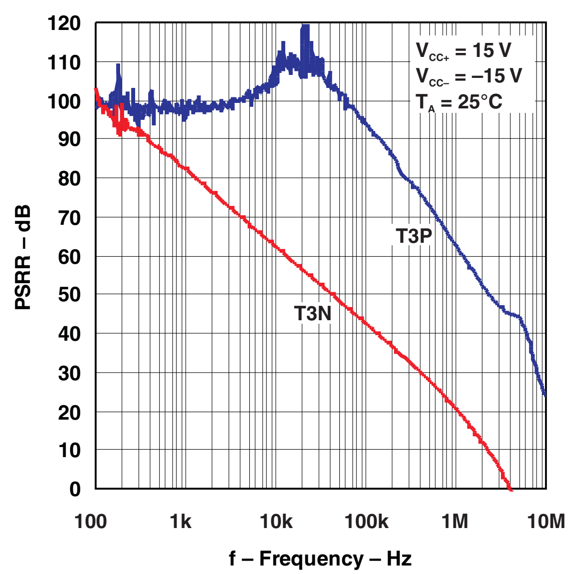
SUPPLY CURRENT
vs
TEMPERATURE



CMRR
vs
FREQUENCY

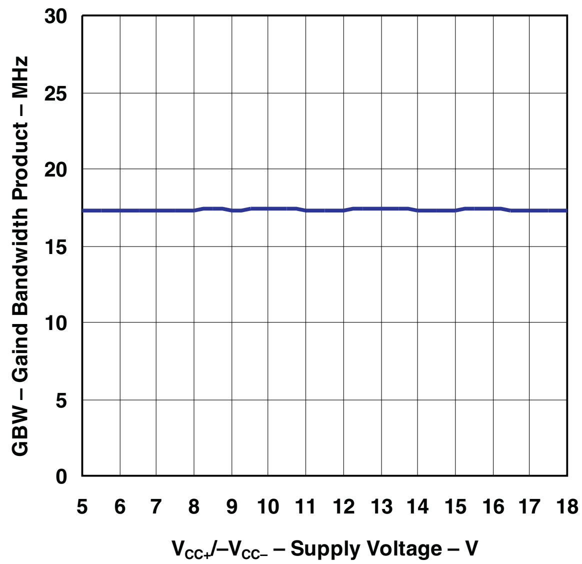


PSSR
vs
FREQUENCY

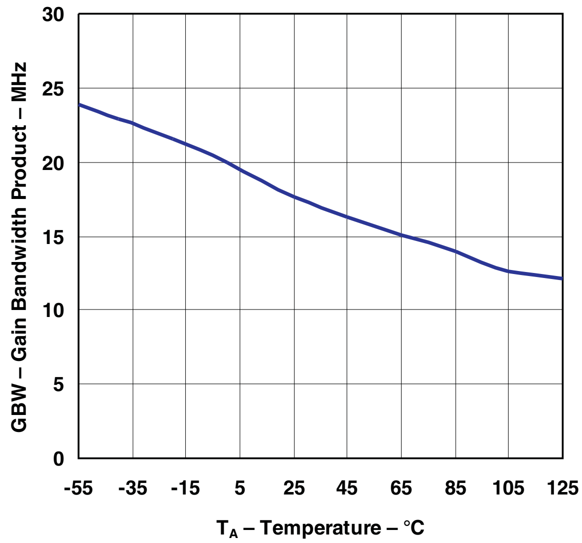


TYPICAL CHARACTERISTICS (continued)

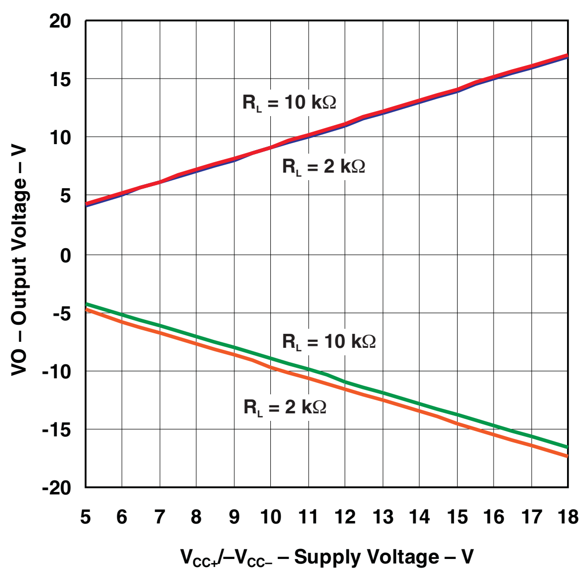
GAIN BANDWIDTH PRODUCT vs SUPPLY VOLTAGE



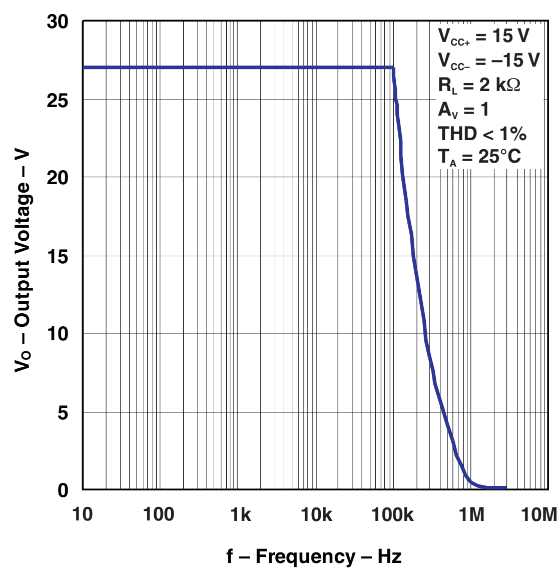
GAIN BANDWIDTH PRODUCT vs TEMPERATURE



OUTPUT VOLTAGE vs SUPPLY VOLTAGE

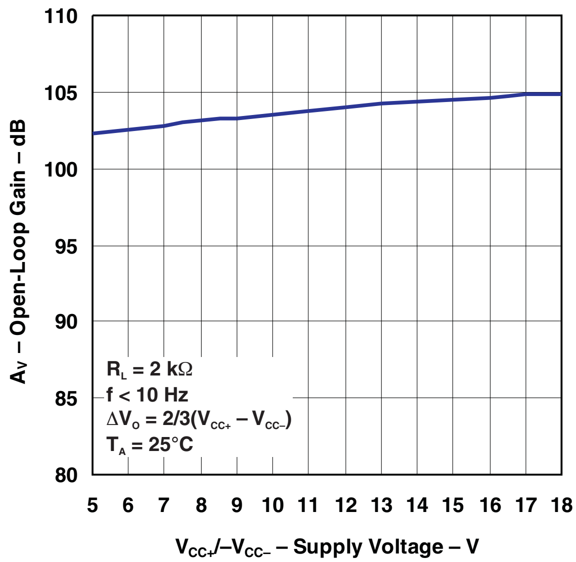


OUTPUT VOLTAGE vs FREQUENCY

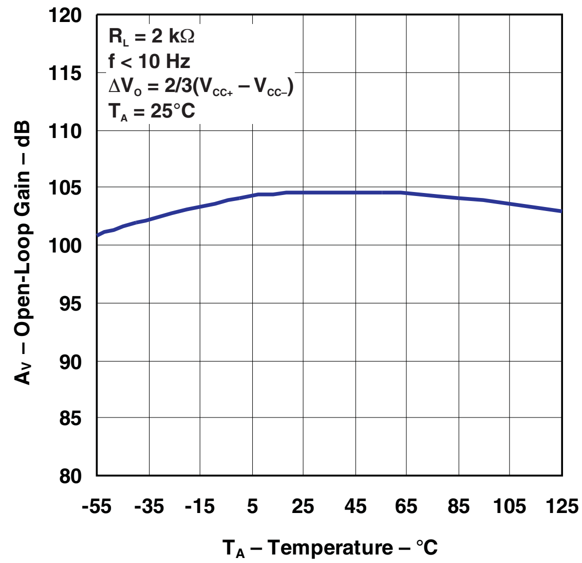


TYPICAL CHARACTERISTICS (continued)

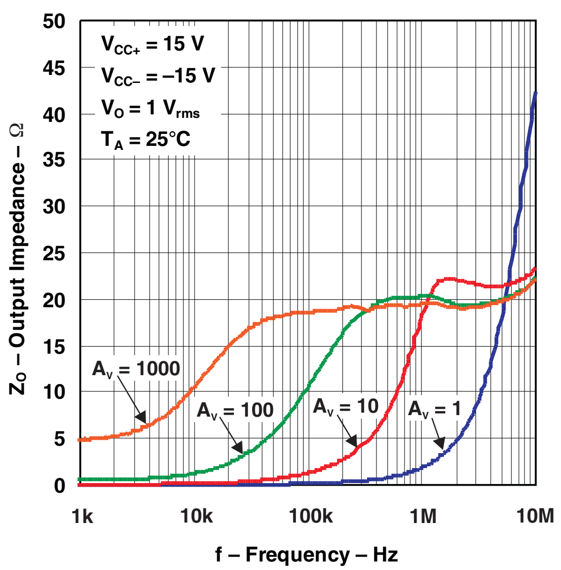
OPEN-LOOP GAIN
vs
SUPPLY VOLTAGE



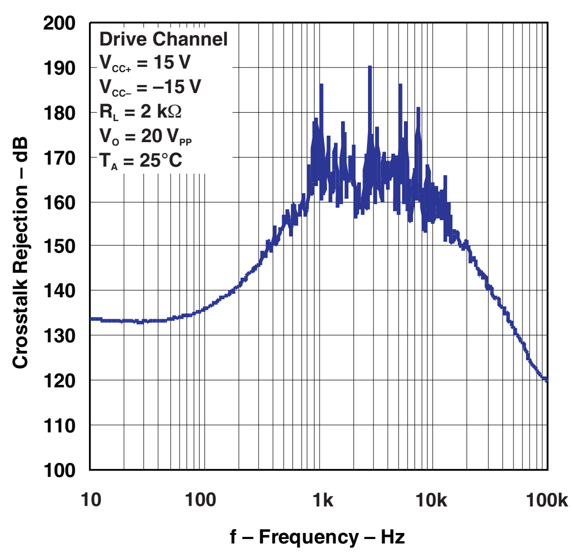
OPEN-LOOP GAIN
vs
TEMPERATURE



OUTPUT IMPEDANCE
vs
FREQUENCY

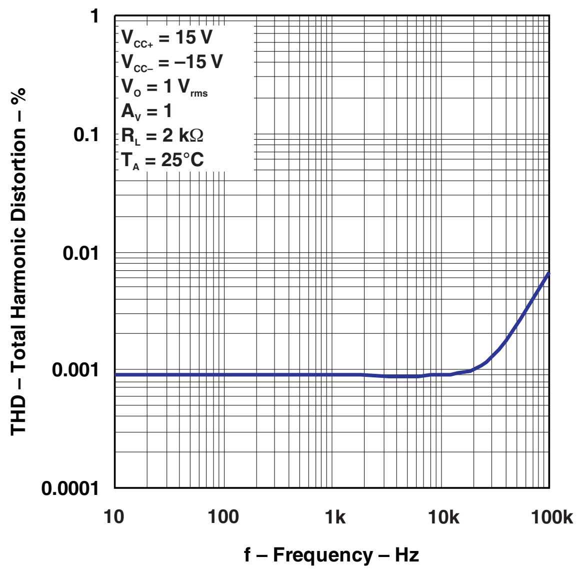


CROSSTALK REJECTION
vs
FREQUENCY

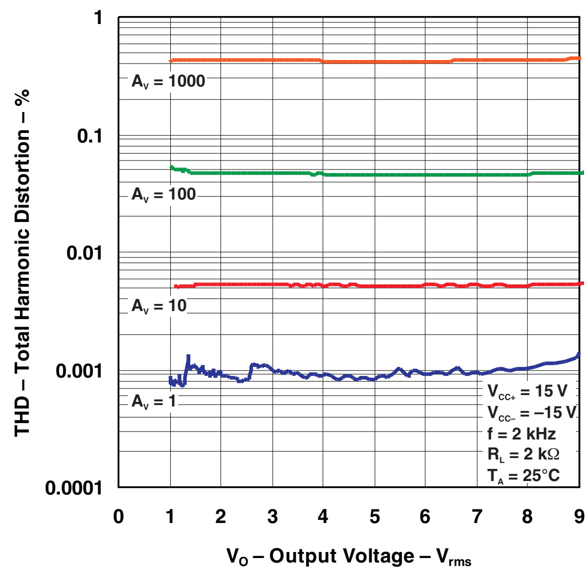


TYPICAL CHARACTERISTICS (continued)

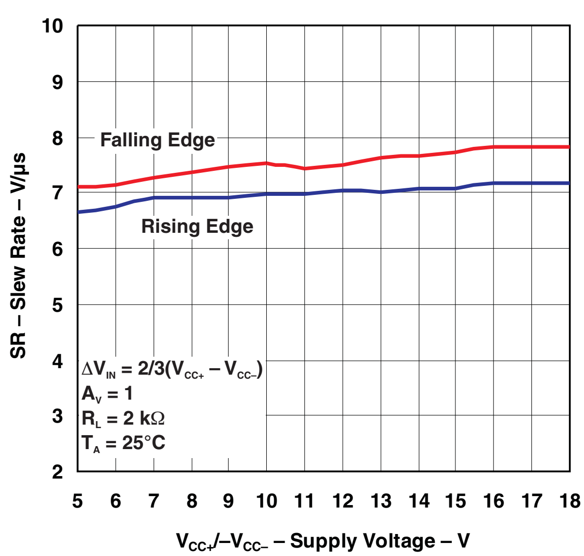
TOTAL HARMONIC DISTORTION
vs
FREQUENCY



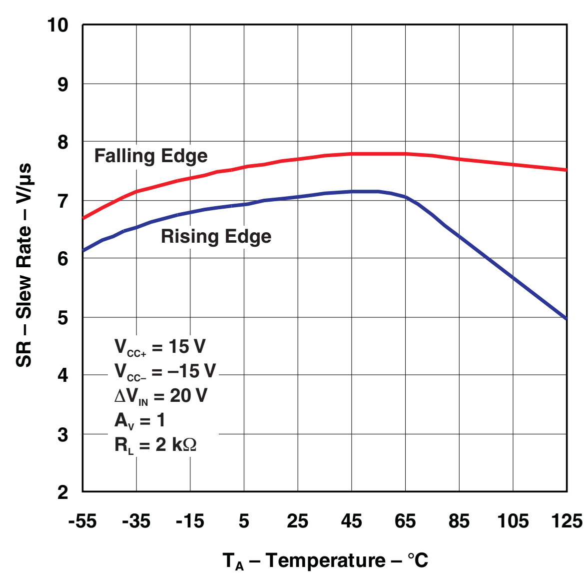
TOTAL HARMONIC DISTORTION
vs
OUTPUT VOLTAGE



SLEW RATE
vs
SUPPLY VOLTAGE

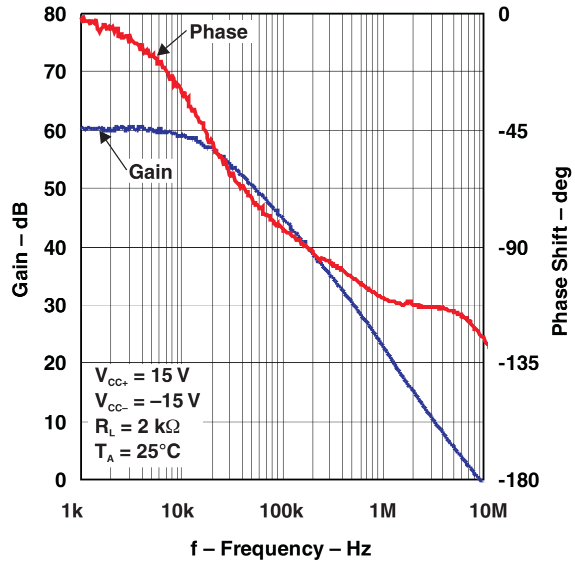


SLEW RATE
vs
TEMPERATURE

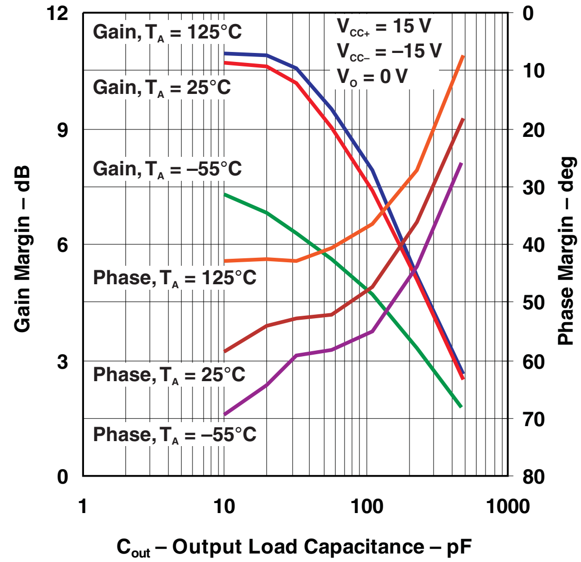


TYPICAL CHARACTERISTICS (continued)

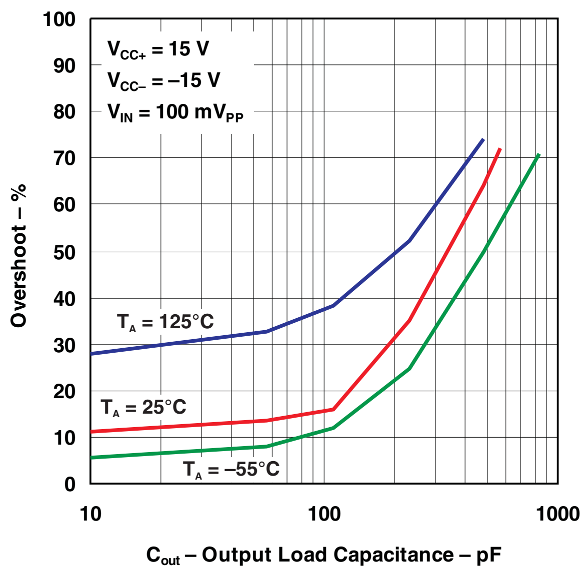
GAIN AND PHASE
vs
FREQUENCY



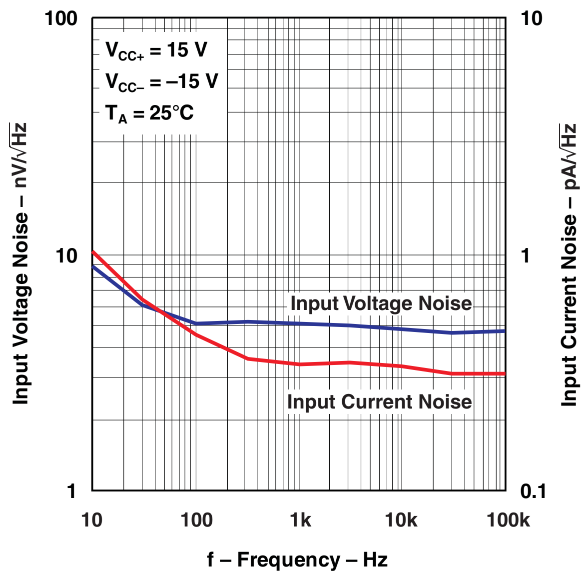
GAIN AND PHASE MARGIN
vs
OUTPUT LOAD CAPACITANCE



OVERSHOOT
vs
OUTPUT LOAD CAPACITANCE

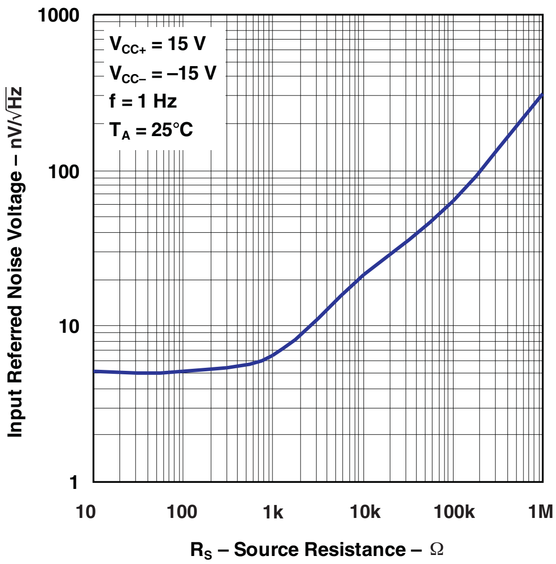


INPUT VOLTAGE AND CURRENT NOISE
vs
FREQUENCY

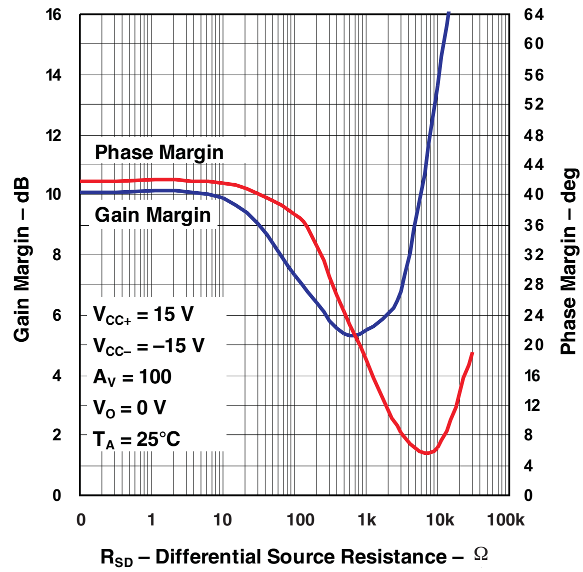


TYPICAL CHARACTERISTICS (continued)

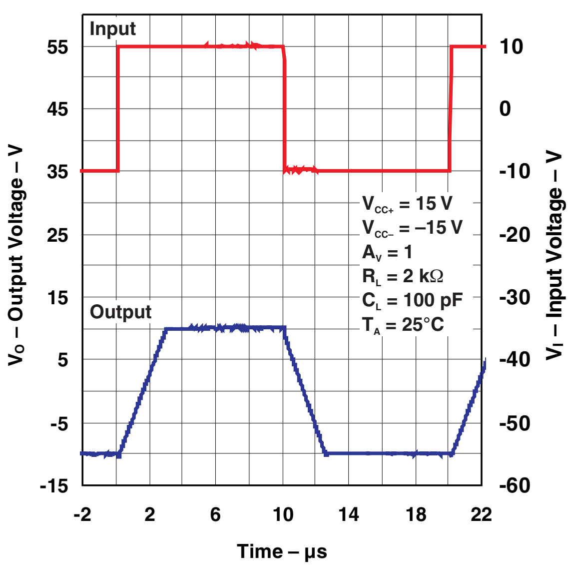
INPUT REFERRED NOISE VOLTAGE
vs
SOURCE RESISTANCE



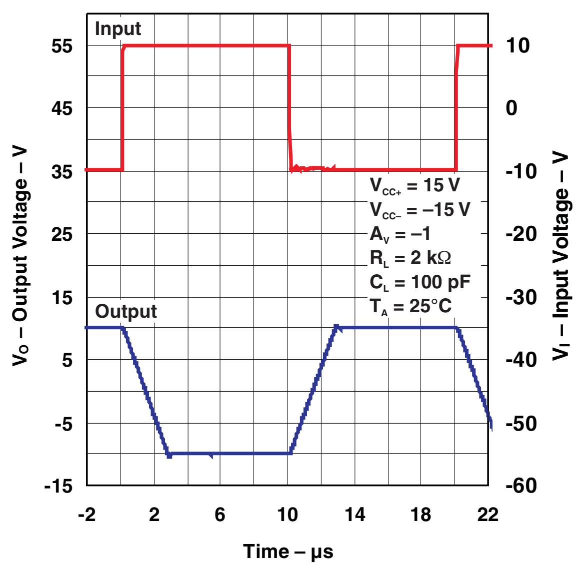
GAIN AND PHASE MARGIN
vs
DIFFERENTIAL SOURCE RESISTANCE



LARGE SIGNAL TRANSIENT RESPONSE
(A_V = 1)

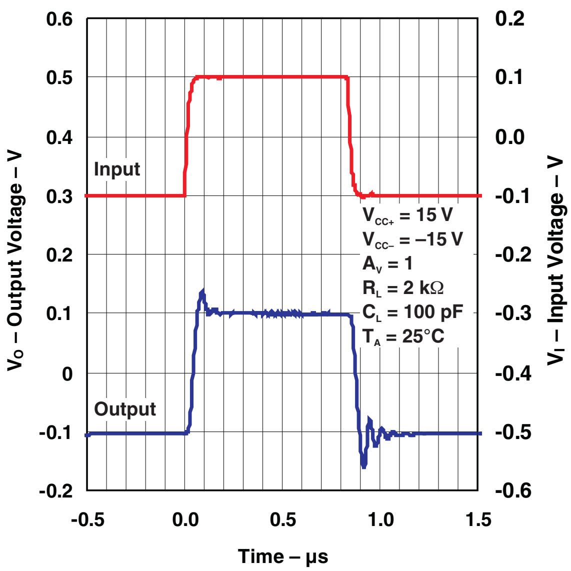


LARGE SIGNAL TRANSIENT RESPONSE
(A_V = –1)

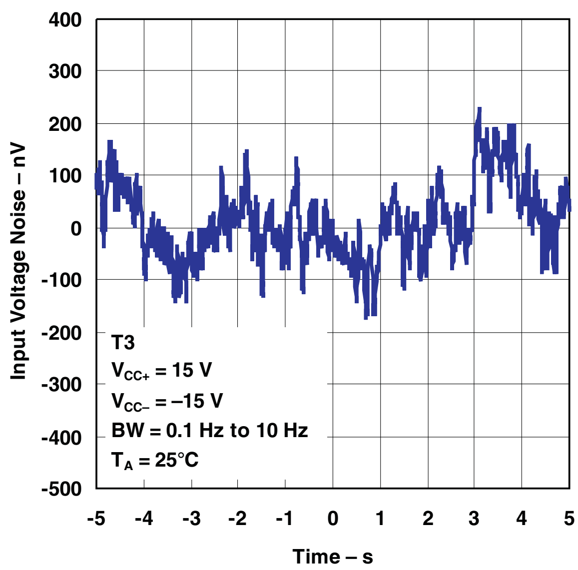


TYPICAL CHARACTERISTICS (continued)

SMALL SIGNAL TRANSIENT RESPONSE



LOW_FREQUENCY NOISE

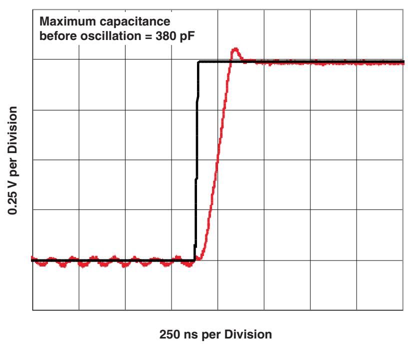


APPLICATION INFORMATION

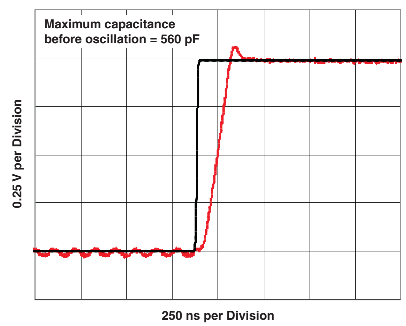
Output Characteristics

All operating characteristics are specified with 100-pF load capacitance. The MC33078 can drive higher capacitance loads. However, as the load capacitance increases, the resulting response pole occurs at lower frequencies, causing ringing, peaking, or oscillation. The value of the load capacitance at which oscillation occurs varies from lot to lot. If an application appears to be sensitive to oscillation due to load capacitance, adding a small resistance in series with the load should alleviate the problem (see Figure 2).

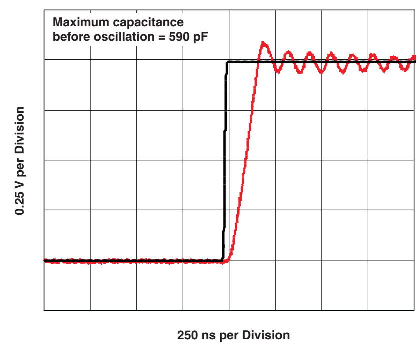
PULSE RESPONSE
(R_L = 600 Ω, C_L = 380 pF)



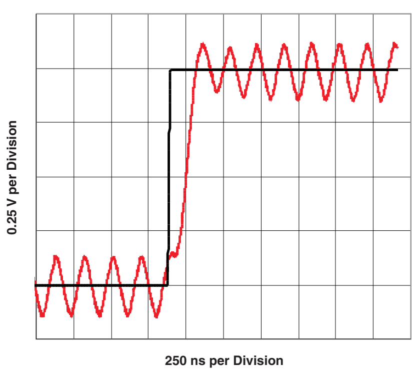
PULSE RESPONSE
(R_L = 2 kΩ, C_L = 560 pF)



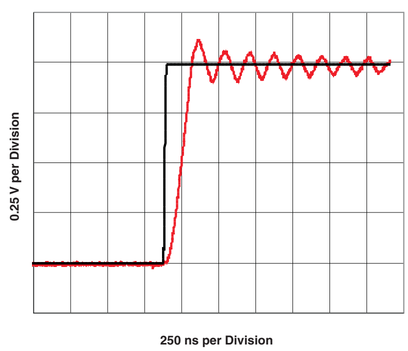
PULSE RESPONSE
(R_L = 10 kΩ, C_L = 590 pF)



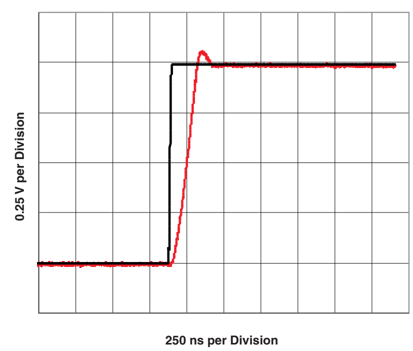
PULSE RESPONSE
(R_O = 0 Ω, C_O = 1000 pF, R_L = 2 kΩ)



PULSE RESPONSE
(R_O = 4 Ω, C_O = 1000 pF, R_L = 2 kΩ)



PULSE RESPONSE
(R_O = 35 Ω, C_O = 1000 pF, R_L = 2 kΩ)



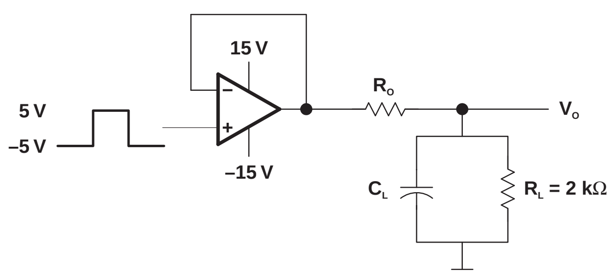


Figure 2. Output Characteristics

PACKAGING INFORMATION

Orderable Device	Status [1]	Package Type	Package Drawing	Pins	Package Qty	Eco Plan [2]	Lead/Ball Finish	MSL Peak Temp [3]
MC33078D	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078DE4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078DG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078DGKR	ACTIVE	MSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078DGKRG4	ACTIVE	MSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078DGKT	ACTIVE	MSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078DGKTG4	ACTIVE	MSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078DR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078DRE4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078DRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MC33078P	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
MC33078PE4	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

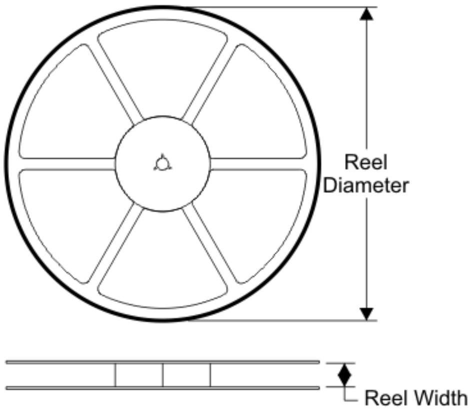
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

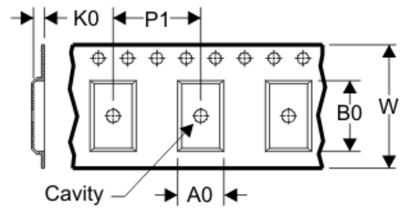
31-Oct-2007

TAPE AND REEL BOX INFORMATION

REEL DIMENSIONS

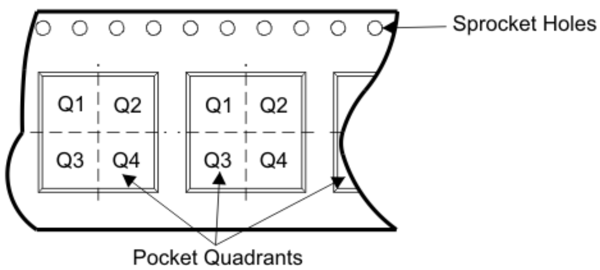


TAPE DIMENSIONS



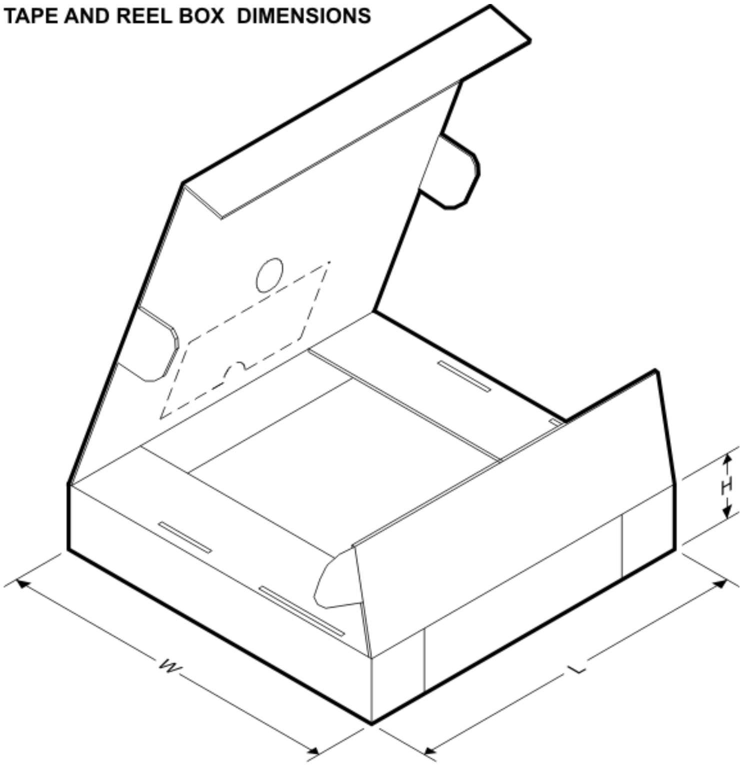
A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



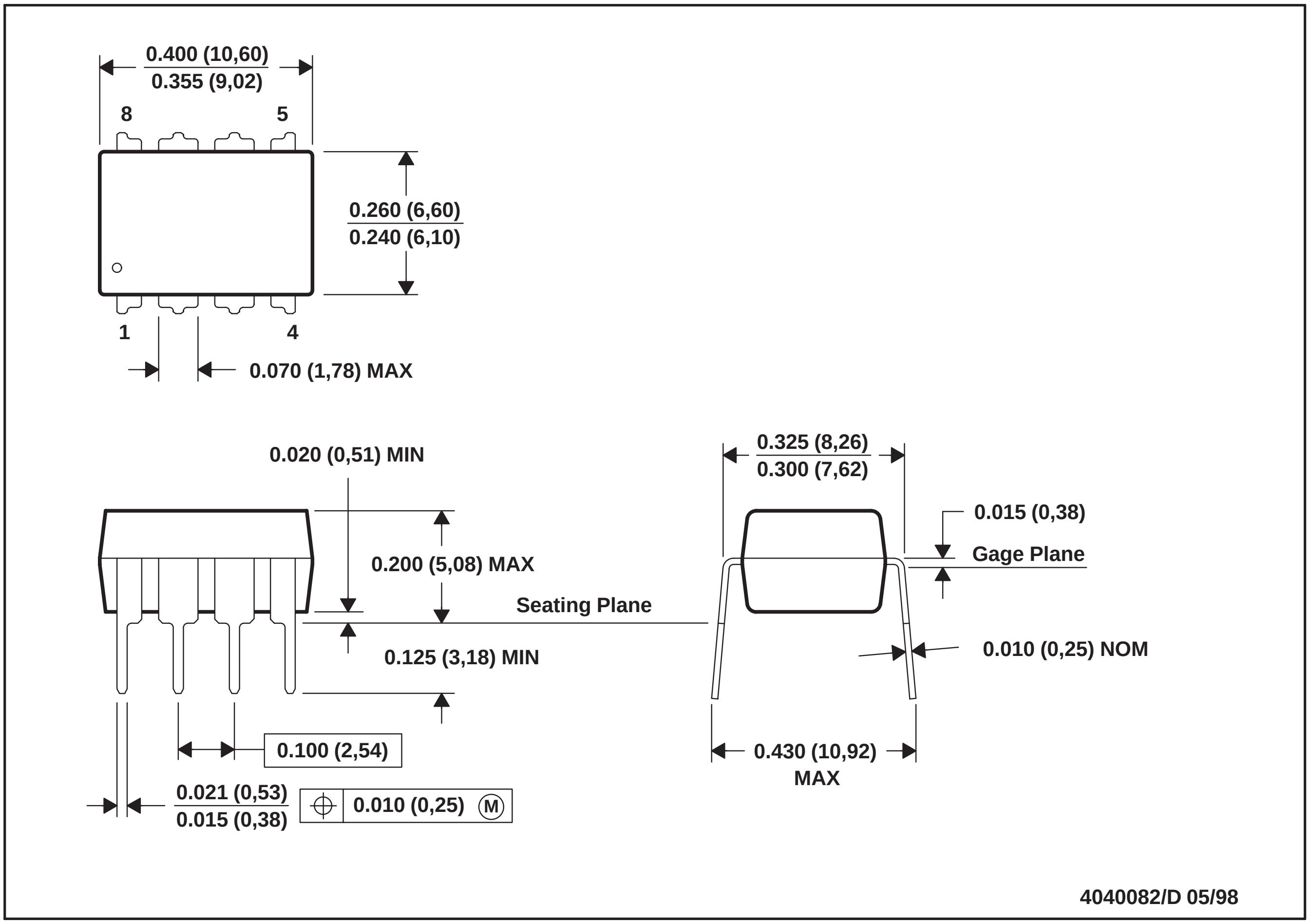
Device	Package	Pins	Site	Reel Diameter (mm)	Reel Width (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MC33078DGKR	DGK	8	SITE 47	330	12	5.3	3.3	1.3	8	12	Q1
MC33078DGKT	DGK	8	SITE 47	180	12	5.3	3.3	1.3	8	12	Q1
MC33078DR	D	8	SITE 27	330	12	6.4	5.2	2.1	8	12	Q1
MC33078DR	D	8	SITE 41	330	12	6.4	5.2	2.1	8	12	Q1

TAPE AND REEL BOX DIMENSIONS



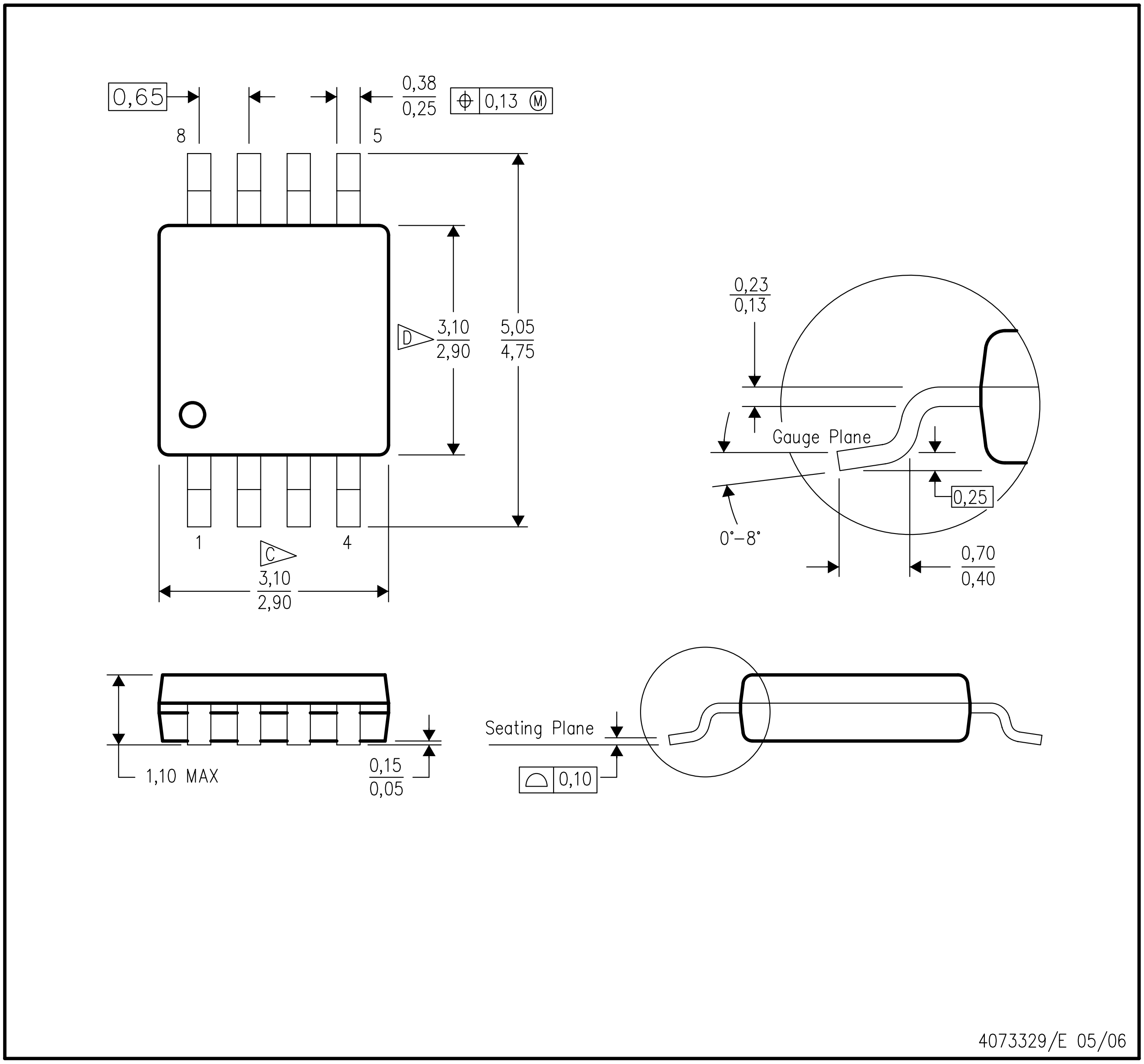
Device	Package	Pins	Site	Length (mm)	Width (mm)	Height (mm)
MC33078DGKR	DGK	8	SITE 47	370.0	355.0	55.0
MC33078DGKT	DGK	8	SITE 47	220.0	205.0	50.0
MC33078DR	D	8	SITE 27	342.9	336.6	20.64
MC33078DR	D	8	SITE 41	346.0	346.0	29.0

P (R-PDIP-T8) **PLASTIC DUAL-IN-LINE**



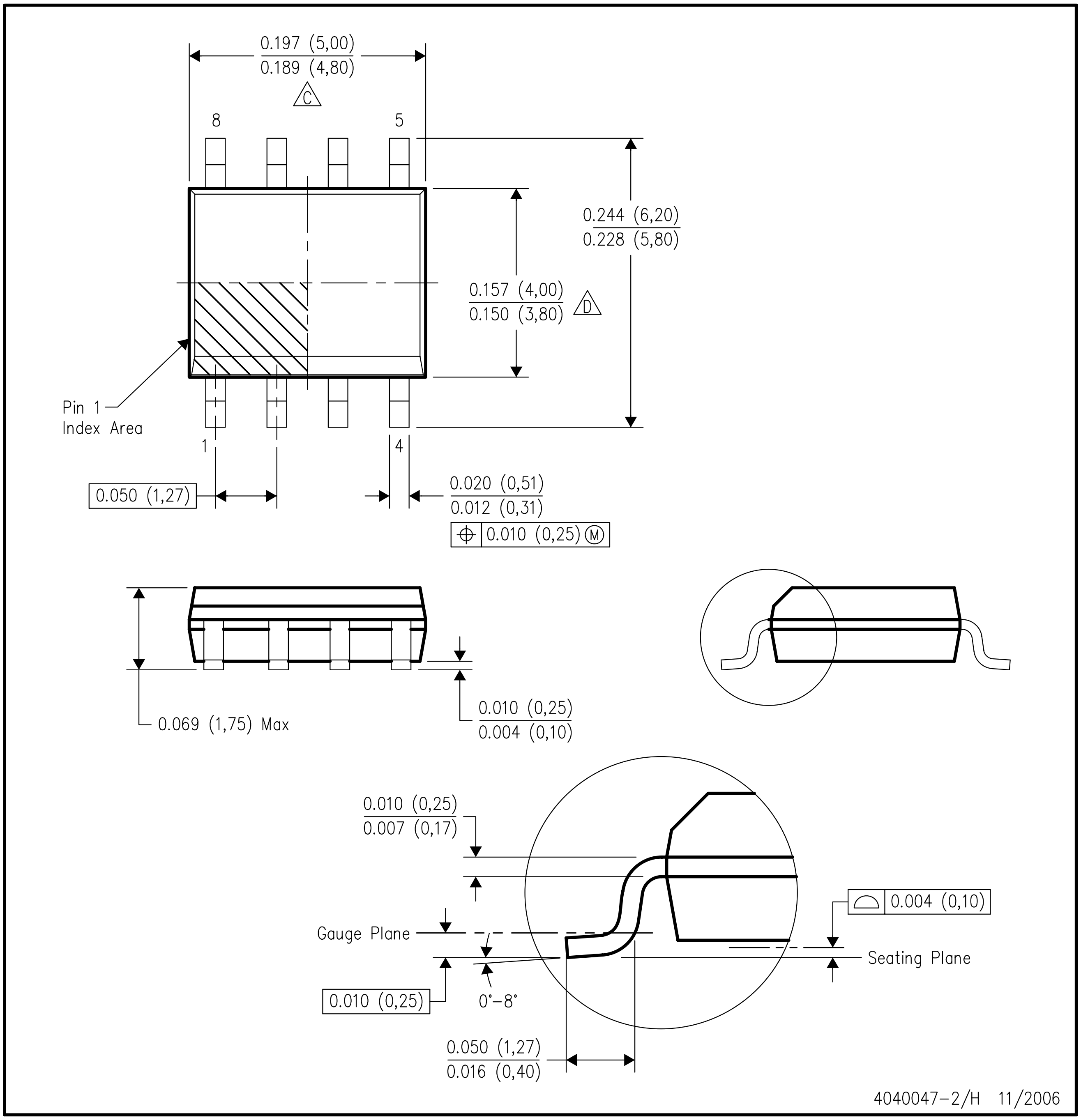
NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS-001

DGK (S-PDSO-G8) PLASTIC SMALL-OUTLINE PACKAGE



NOTES:
- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
- D. Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.

D (R-PDSO-G8) PLASTIC SMALL-OUTLINE PACKAGE



NOTES:
- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- D. Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AA.